

Notice of References Cited	Application/Control No. 10/804,080		Applicant(s)/Patent Under Reexamination TAKEDA ET AL.	
	Examiner CHAN S. PARK		Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0225890	11-2004	Kang et al.	713/193
*	C	US-2006/0044589	03-2006	Nakagawaji, Shuichi	358/001.14
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NON-PATENT DOCUMENTS

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